

10/587576

IAP11 Rec'd PCT/PTO 31 JUL 2006 Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 128877		APPLICATION NO. New U.S. National Phase of PCT/JP2005/006230	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Shigeki NAKAYAMA et al. FILING DATE July 31, 2006			
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
/HHH/	1.	6,530,361 B1	03/11/2003	SHIRAISHI et al.			
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/HHH/	2.	DE 100 32 232 A1	02/15/2001	GERMANY			
/HHH/	3.	EP 1 310 649 A1	05/14/2003	EUROPE			
/HHH/	4.	WO 03/016698 A1	02/27/2003	WIPO			
/HHH/	5.	EP 1 365 134 A2	11/26/2003	EUROPE			
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EXAMINER				/Hai Huynh/ (11/07/2007)		DATE CONSIDERED	
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: July 31, 2006

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128877APPLICATION NO.
10/587,576

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Shigeki NAKAYAMA et al.FILING DATE
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U.S. PATENT DOCUMENTS

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Date: August 29, 2007